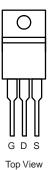


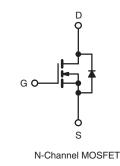
P25NM50N-VB Datasheet

N-Channel 500-V (D-S) Super Junction MOSFET

| PRODUCT SUMMARY | | | | |
|--|------------------------------|--|--|--|
| V _{DS} (V) at T _J max. | 500 | | | |
| R _{DS(on)} at 25 °C (Ω) | V _{GS} = 10 V 0.115 | | | |
| Q _g (Max.) (nC) | 86 | | | |
| Q _{gs} (nC) | 14 | | | |
| Q _{gd} (nC) | 25 | | | |
| Configuration | Single | | | |

TO-220AB





FEATURES

- Low figure-of-merit (FOM): Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Low gate charge (Q_g)
- Avalanche energy rated (UIS)

APPLICATONS

- · Hard switched topologies
- Power factor correction power supplies (PFC)
- Switch mode power supplies (SMPS)
- Computing
 - PC silver box / ATX power supplies
- Lighting
- Two stage LED lighting

| ABSOLUTE MAXIMUM RATINGS (T _C : | = 25 °C, unl | ess otherwis | se noted) | | | |
|---|-------------------------|---|-------------------|-------|------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | V _{DS} | 500 | V | | |
| Gate-Source Voltage | | | V _{GS} | ± 30 | | |
| Continuous Drain Current (T ₁ = 150 °C) | V at 10 V | T _C = 25 °C T _C = 100 °C | I _D 30 | 30 | A | |
| Continuous Drain Current $(1_j = 150 \text{ C})$ | V _{GS} at 10 V | T _C = 100 °C | | 18 | | |
| Pulsed Drain Current ^a | | I _{DM} | 105 | | | |
| Linear Derating Factor | | | 0.2 | W/°C | | |
| Single Pulse Avalanche Energy ^b | | E _{AS} | 273 | mJ | | |
| Maximum Power Dissipation | | | PD | 280 | W | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | -55 to +150 | °C | | |
| Drain-Source Voltage Slope $V_{DS} = 0 V to 80 \% V_{DS}$ | | dV/dt 65 25 | 65 | | | |
| Reverse Diode dV/dt ^d | | | 25 | V/ns | | |
| Soldering Recommendations (Peak Temperature) c for 10 s | | | 300 | °C | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.4 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D,\, dl/dt$ = 100 A/µs, starting T_J = 25 °C.

| THERMAL RESISTANCE RATINGS | | | | |
|----------------------------------|-------------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R _{thJA} | - | 40 | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | 0.5 | 0/10 |

| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|-----------------------|---|--|------|-------|------|------|
| Static | | | | | • | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} : | = 0 V, I _D = 250 μA | 500 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Referenc | e to 25 °C, I _D = 1 mA | - | 0.59 | - | V/°C |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μΑ | 2.0 | - | 4.0 | V |
| | | V _{GS} = ± 20 V | | - | ± 100 | nA | |
| Gate-Source Leakage | I _{GSS} | | V _{GS} = ± 30 V | - | - | ± 1 | μA |
| Zava Cata Valtaga Dirain Current | | V _{DS} = | = 500 V, V _{GS} = 0 V | - | - | 1 | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 400 V | /, V _{GS} = 0 V, T _J = 125 °C | - | - | 25 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | $V_{GS} = 10 V$ | I _D = 12 A | - | 0.115 | - | Ω |
| Forward Transconductance | g fs | V _{DS} | = 30 V, I _D = 12 A | - | 6.6 | - | S |
| Dynamic | | | | • | • | • | |
| Input Capacitance | C _{iss} | | V _{GS} = 0 V, | - | 1980 | - | |
| Output Capacitance | C _{oss} | | V _{DS} = 100 V, | - | 105 | - | |
| Reverse Transfer Capacitance | C _{rss} | | | | 8 | - | 1 |
| Effective Output Capacitance, Energy Related ^a | C _{o(er)} | V _{DS} = 0 V to 400 V, V _{GS} = 0 V | | 105 | - | pF | |
| Effective Output Capacitance, Time Related ^b | C _{o(tr)} | | | - | 285 | - | 1 |
| Total Gate Charge | Qg | | | - | 57 | 86 | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | I _D = 12 A, V _{DS} = 400 V | - | 14 | - | nC |
| Gate-Drain Charge | Q _{gd} | | | - | 25 | - | |
| Turn-On Delay Time | t _{d(on)} | | | - | 19 | 38 | |
| Rise Time | t _r | V _{DD} = | = 400 V, I _D = 12 A | - | 36 | 72 | |
| Turn-Off Delay Time | t _{d(off)} | $R_{g} = 9.1 \ \Omega, \ V_{GS} = 10 \ V - 57 \ 80$ | | 86 | ns | | |
| Fall Time | t _f | | | 29 | 58 | 1 | |
| Gate Input Resistance | Rg | f = 1 | MHz, open drain | - | 0.56 | - | Ω |
| Drain-Source Body Diode Characteristic | s | | | | | | |
| Continuous Source-Drain Diode Current | IS | MOSFET syml showing the | | - | - | 12 | |
| Pulsed Diode Forward Current | I _{SM} | integral reverse | | - | - | 50 | A |
| Diode Forward Voltage | V_{SD} | $T_{\rm J} = 25 ^{\circ}\text{C}, I_{\rm S} = 16.5 \text{A}, V_{\rm GS} = 0 \text{V}$ | | - | - | 1.2 | V |
| Reverse Recovery Time | t _{rr} | | | - | 338 | - | ns |
| Reverse Recovery Charge | Q _{rr} | T _J = 25 °C, $I_F = I_S$, dl/dt = 100 A/µs, $V_B = 25$ V - 5.3 | | - | μC | | |
| Reverse Recovery Current | I _{RRM} | u/ul = | $100 \text{ rv} \mu \text{s}, \text{ v}_{\text{R}} = 23 \text{ v}$ | - | 29 | - | Α |

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

mi



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

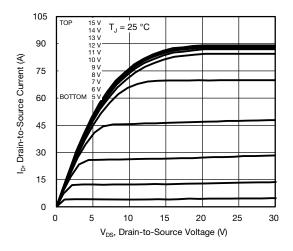


Fig. 1 - Typical Output Characteristics

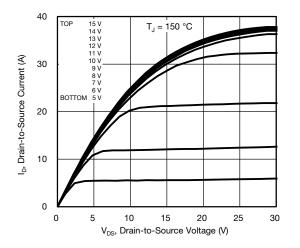


Fig. 2 - Typical Output Characteristics

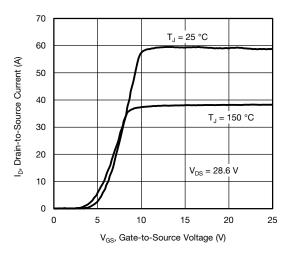


Fig. 3 - Typical Transfer Characteristics

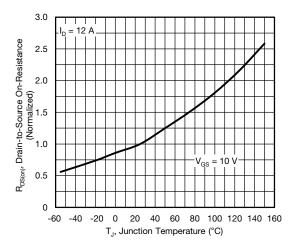


Fig. 4 - Normalized On-Resistance vs. Temperature

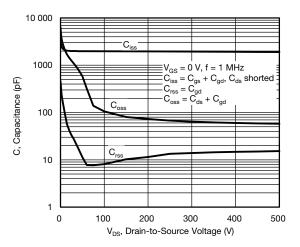


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

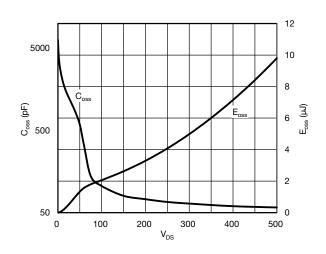


Fig. 6 - C_{OSS} and E_{OSS} vs. V_{DS}

P25NM50N-VB

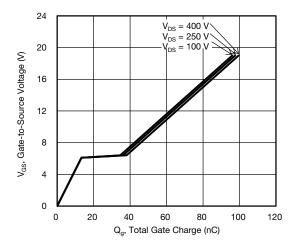


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

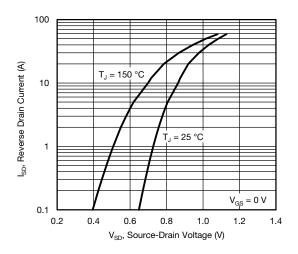


Fig. 8 - Typical Source-Drain Diode Forward Voltage

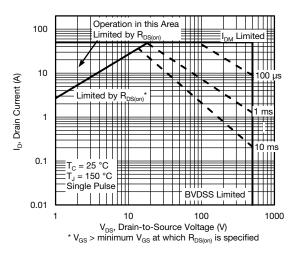
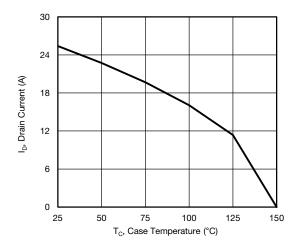


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

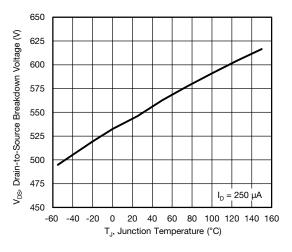


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature

P25NM50N-VB

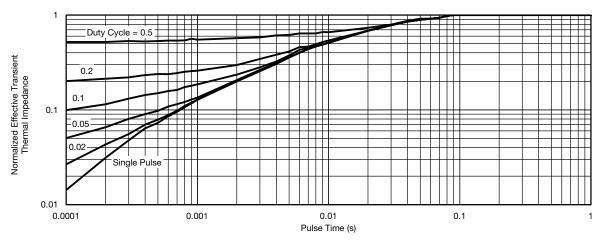


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

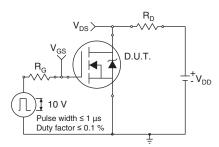


Fig. 13 - Switching Time Test Circuit

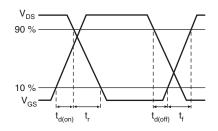


Fig. 14 - Switching Time Waveforms

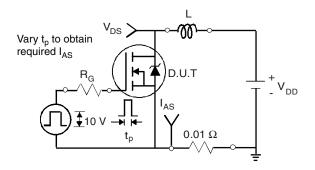


Fig. 15 - Unclamped Inductive Test Circuit

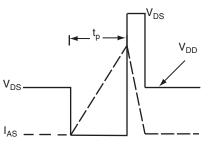


Fig. 16 - Unclamped Inductive Waveforms

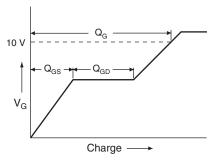


Fig. 17 - Basic Gate Charge Waveform

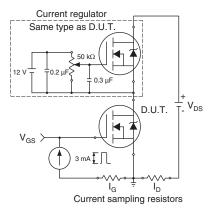


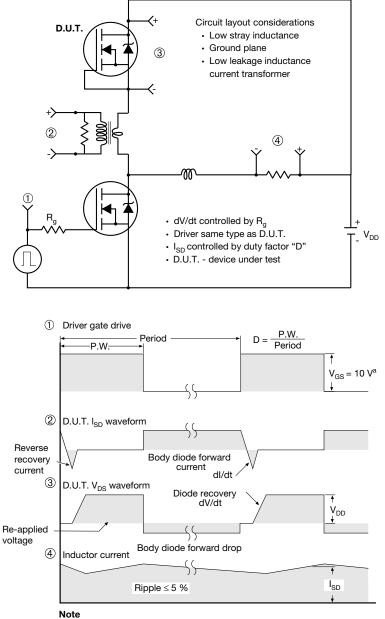
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit

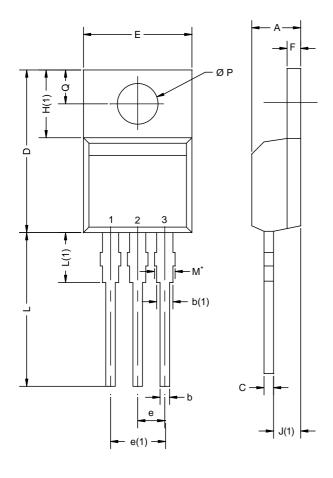


a. V_{GS} = 5 V for logic level devices

Fig. 19 - For N-Channel



TO-220AB



| | MILLIN | IETERS | INC | HES |
|-----------------------|-------------------|-----------|-------|-------|
| DIM. | MIN. | MAX. | MIN. | MAX. |
| А | 4.25 | 4.65 | 0.167 | 0.183 |
| b | 0.69 | 1.01 | 0.027 | 0.040 |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 |
| С | 0.36 | 0.61 | 0.014 | 0.024 |
| D | 14.85 | 15.49 | 0.585 | 0.610 |
| E | 10.04 | 10.51 | 0.395 | 0.414 |
| е | 2.41 | 2.67 | 0.095 | 0.105 |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 |
| F | 1.14 | 1.40 | 0.045 | 0.055 |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 |
| L | 13.35 | 14.02 | 0.526 | 0.552 |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 |
| ØР | 3.54 | 3.94 | 0.139 | 0.155 |
| Q | 2.60 | 3.00 | 0.102 | 0.118 |
| ECN: X12- DWG: 547 | 0208-Rev. N, 1 | 08-Oct-12 | | |

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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